


Search Notes 	Application/Control No. 10585733	Applicant(s)/Patent Under Reexamination ICHIKAWA, TAKESHI
	Examiner SELIM AHMED	Art Unit 2826

SEARCHED			
Class	Subclass	Date	Examiner
438	57, 59, 60, 73, 78	11/9/08	/sa/
257	291, 292	11/9/08	/sa/
	Updated search	6/7/2009	/sa/
	Updated search	12/16/2009	/sa/

SEARCH NOTES		
Search Notes	Date	Examiner
Test search such as, buried channel, surface channel, image sensor, CMOS sensor, photoelectric, pixel, transistor, substrate and their boolean combinations were searched.	11/9/08	/sa/
Updated search	6/7/2009	/sa/
Inventor and interference search	12/16/2009	/sa/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
438	59, 60, 78	12/16/2009	/sa/
257	291, 292	12/16/2009	/sa/

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